Search Notes				

Application/Control No.	Applicant(s)/Patent unde Reexamination	Applicant(s)/Patent under Reexamination	
10/582,036	BURKART ET AL.	BURKART ET AL.	
Examiner	Art Unit		
Tianjie Chen	2627		

SEARCHED				
Examiner				
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
675	12/12/2007	ŢJ			
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	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Report	12/12/2007	ΤJ	
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